Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/748,152	LEE ET AL.		
Examiner	Art Unit	_	
Yonel Beaulieu	3661		

	SEARCHED					
Class	Subclass	Date	Examiner			
701	41-44	11/19/2005	YB			
180	6.2	11/19/2005	YB			
	443					
280	5.51	11/20/2005	YB			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARC (INCLUDING SE	CH NOT ARCH	ES STRATEGY)	)
		DATE	EXMR
WEST (Fwd/Bwd)		11/20/2005	YB
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